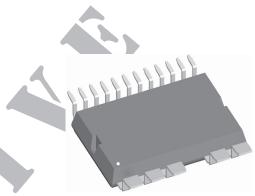


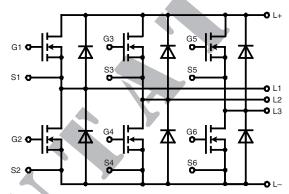
Three phase full Bridge

with Trench MOSFETs in DCB-isolated high-current package

V _{DSS}	=	55 V
D25	=	150 A
R _{DSon typ.}	=	2.2 m Ω

Part number MTC120W55GC





Features / Advantages:

- MOSFETs in trench technology:
 - low $R_{\mbox{\tiny DSon}}$
- optimized intrinsic reverse diodePackage:
 - high level of integration
 - high current capability
 - aux. terminals for MOSFET control
 terminals for soldering or welding
 - connections – isolated DCB ceramic base plate
 - isolated DCB ceramic base plate with optimized heat transfer
- · Space and weight savings

Applications:

- AC drives
- in automobiles
- electric power steering
- starter generator
- in industrial vehicles
 - propulsion drives
 - fork lift drives
- in battery supplied equipment

Package: ISOPLUS-DIL®

- · High level of integration
- · RoHS compliant
- High current capability
- Aux. Terminals
 - for MOSFET control
- Terminals for soldering or welding connections
- · Space and weight savings

Terms & Conditions of usage
The data contained in this product data sheet is exclusively intended for technically trained staff. The user will have to evaluate the suitability of the product for the intended application and the completeness of
the product data with respect to his application. The specifications of our components may not be considered as an assurance of component characteristics. The information in the valid application- and assembly
notes must be considered. Should you require product information in excess of the data given in this product data sheet or which concerns the specific application of your product, please contact your local sales

office. Due to technical requirements our product may contain dangerous substances. For information on the types in question please contact your local sales office. Should you intend to use the product in aviation, in health or life endangering or life support applications, please notify. For any such application we urgently recommend

to perform joint risk and quality assessments;
the conclusion of quality agreements;

- to establish joint measures of an ongoing product survey, and that we may make delivery dependent on the realization of any such measures.

IXYS reserves the right to change limits, test conditions and dimensions.

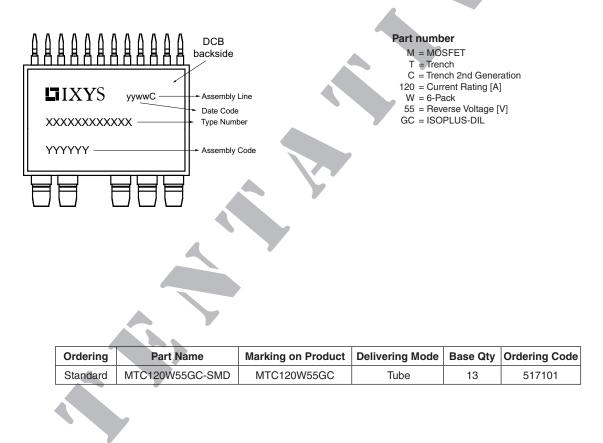
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MOSFETs		Ratings					
Symbol	Definitions	Conditions		min.	typ.	max.	Unit
V _{DSS}	drain source breakdown voltage	$T_{VJ} = 2$	25°C to 150°C			55	V
V _{GS} V _{GSM}	gate source voltage max. transient gate source voltage					±15 ±20	V V
_{D25} _{D80} _{D100}	continuous drain current		$\begin{array}{rcl} T_{\rm C} &=& 25^{\circ}{\rm C} \\ T_{\rm C} &=& 80^{\circ}{\rm C} \\ T_{\rm C} &=& 100^{\circ}{\rm C} \end{array}$			150 120 106	A A A
R _{DS(on)} ¹⁾	static drain source on resistance	on chip level at $I_D = 100 \text{ A}; V_{GS} = 10 \text{ V}$	$T_{VJ} = 25^{\circ}C$ $T_{VJ} = 125^{\circ}C$		2.2 3.7	3.1 5.3	mΩ mΩ
V _{GS(th)}	gate threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$	$T_{VJ} = 25^{\circ}C$	3.0		4.0	V
I _{DSS}	drain source leakage current	$V_{\text{DS}} = V_{\text{DSS}}; V_{\text{GS}} = 0 \text{ V}$	T _{vJ} = 25°C T _{vJ} = 125°C		50	1	μΑ μΑ
I _{GSS}	gate source leakage current	$V_{GS} = \pm 20 \text{ V}; V_{DS} = 0 \text{ V}$				500	nA
R _G	gate resistance	on chip level					Ω
C _{iss} C _{oss} C _{rss}	input capacitance output capacitance reverse transfer capacitance	$V_{GS} = 0 \text{ V}; \text{ V}_{DS} = 25 \text{ V}; \text{ f} = 1 \text{ Mhz}$			6.97 1.03 230		nF nF pF
Q _g Q _{gs} Q _{gd}	total gate charge gate source charge gate drain (Miller) charge	$V_{GS} = 10 \text{ V}; \text{ V}_{DS} = 28 \text{ V}; \text{ I}_{D} = 100 \text{ A}$			100 35 25		nC nC nC
$t_{d(on)}$ t_r $t_{d(off)}$ t_f E_{on} E_{off} $E_{rec(off)}$	turn-on delay time current rise time turn-off delay time current fall time turn-on energy per pulse turn-off energy per pulse turn-off reverse recovery losses	inductive load $V_{GS} = 10 \text{ V}; V_{DS} = 24 \text{ V}$ $I_D = 100 \text{ A}; R_G = 39 \Omega$	T _{vJ} = 125°C		100 110 500 100 0.12 0.53 0.01		ns ns ns mJ mJ mJ
R _{thJC}	thermal resistance junction to case					1.0	
R _{thJH}	thermal resistance junction to heatsink	with heat transfer paste (IXYS tes	st setup)		1.3		K/W
	4	¹⁾ V _{DS} = I _D · (R _{DS(on)} + 2 · R _{Pin to Chip})	.,				
Source-	Drain Diode						
_{F25} _{F80} _{F100}	forward current	$V_{GS} = 0 V$	$\begin{array}{rcl} T_{\rm C} &=& 25^{\circ}{\rm C} \\ T_{\rm C} &=& 80^{\circ}{\rm C} \\ T_{\rm C} &=& 100^{\circ}{\rm C} \end{array}$			140 95 80	A A A
$V_{\rm SD}$	source drain voltage	$I_{F} = 100 \text{ A}; V_{GS} = 0 \text{ V}$	$T_{VJ} = 25^{\circ}C$		0.9	1.2	V
Q _{RM} I _{RM} t _{rr}	reverse recovery charge max. reverse recovery current reverse recovery time	_ V _R = 24 V; I _F = 100 A di/dt = 800 A/μs	$T_{VJ} = 125^{\circ}C$		0.45 22 38		μC A ns



Package ISOPLUS-DIL®			Ratings				
Symbol	Definitions	Conditions		min.	typ.	max.	Unit
I _{RMS}	RMS current		per pin in main current paths (P+, N–, L1, L2, L3) may be additionally limited by external connections (PCB tracks)			300	A
T _{stg}	storage temperature			-55		125	°C
T_{VJM}	virtual junction temperature			-55		175	°C
Weight					25		g
Fc	mounting force with clip					250	Ν
VISOL	isolation voltage	t = 1 second	- 50/60 Hz, RMS, I _{ISOL} ≤ 1 mA.	1200			V
		t = 1 minute		1000			V
R _{pin-chip}	resistance terminal to chip	$V_{DS} = I_D \cdot (R_{DS(on)})$	$V_{DS} = I_{D} \cdot (R_{DS(on)} + 2 \cdot R_{pin to chip})$		0.6		mΩ
C _P	coupling capacity	between shorted	between shorted pins and back side metallization		160		pF



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